# 1. General description

PNP low  $V_{CEsat}$  Breakthrough In Small Signal (BISS) transistor in a leadless ultra small DFN1010D-3 (SOT1215) Surface-Mounted Device (SMD) plastic package with visible and solderable side pads.

NPN complement: PBSS4160QA.

## 2. Features and benefits

- Very low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- High collector current gain h<sub>FE</sub> at high I<sub>C</sub>
- High energy efficiency due to less heat generation
- Reduced Printed-Circuit Board (PCB) area requirements
- Solderable side pads
- AEC-Q101 qualified

## 3. Applications

- Loadswitch
- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

## 4. Quick reference data

Table 1. Quick reference data

| Symbol             | Parameter                               | Conditions  | Min | Тур | Max  | Unit |
|--------------------|---|---|-----|-----|------|------|
| V <sub>CEO</sub>   | collector-emitter voltage               | open base   | -   | -   | -60  | V    |
| I <sub>C</sub>     | collector current                       |   | -   | -   | -1   | Α    |
| I <sub>CM</sub>    | peak collector current                  | $t_p \le 1 \text{ ms; pulsed}$  | -   | -   | -1.5 | Α    |
| R <sub>CEsat</sub> | collector-emitter saturation resistance | $I_C$ = -1 A; $I_B$ = -100 mA; pulsed;<br>$t_p \le 300$ μs; $\delta \le 0.02$ ; $T_{amb}$ = 25 °C | -   | 225 | 330  | mΩ   |





60 V, 1 A PNP low VCEsat (BISS) transistor

# 5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline                        | Graphic symbol |
|-----|--------|-------------|---|----------------|
| 1   | В      | base        |   | C              |
| 2   | Е      | emitter     |   | В              |
| 3   | С      | collector   | 4 3                                       | '*_            |
| 4   | С      | collector   | 2   | sym132         |
|     |        |             | Transparent top view DFN1010D-3 (SOT1215) |                |

# 6. Ordering information

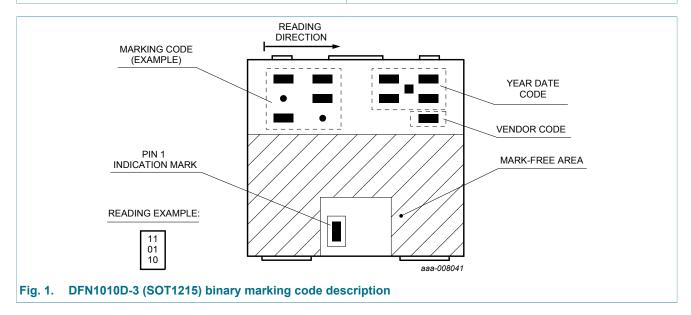
Table 3. Ordering information

| Type number | Package    |  |         |  |  |  |
|-------------|------------|--|---------|--|--|--|
|             | Name       | Description  | Version |  |  |  |
| PBSS5160QA  | DFN1010D-3 | plastic thermal enhanced ultra thin small outline package; no leads; 3 terminals | SOT1215 |  |  |  |

# 7. Marking

Table 4. Marking codes

| Type number | Marking code |
|-------------|--------------|
| PBSS5160QA  | 10 10 10     |



PBSS5160QA

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60 V, 1 A PNP low VCEsat (BISS) transistor

# 8. Limiting values

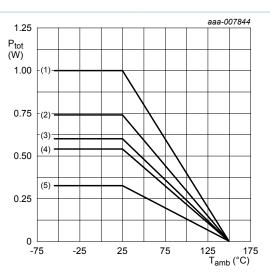
Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter                 | Conditions                    |     | Min | Max  | Unit |
|------------------|---------------------------|-------------------------------|-----|-----|------|------|
| $V_{CBO}$        | collector-base voltage    | open emitter                  |     | -   | -60  | V    |
| $V_{CEO}$        | collector-emitter voltage | open base                     |     | -   | -60  | V    |
| V <sub>EBO</sub> | emitter-base voltage      | open collector                |     | -   | -7   | V    |
| I <sub>C</sub>   | collector current         |                               |     | -   | -1   | Α    |
| I <sub>CM</sub>  | peak collector current    | t <sub>p</sub> ≤ 1 ms; pulsed |     | -   | -1.5 | Α    |
| I <sub>B</sub>   | base current              |                               |     | -   | -0.3 | Α    |
| I <sub>BM</sub>  | peak base current         | t <sub>p</sub> ≤ 1 ms; pulsed |     | -   | -1   | Α    |
| P <sub>tot</sub> | total power dissipation   | T <sub>amb</sub> ≤ 25 °C      | [1] | -   | 325  | mW   |
|                  |                           |                               | [2] | -   | 600  | mW   |
|                  |                           |                               | [3] | -   | 740  | mW   |
|                  |                           |                               | [4] | -   | 540  | mW   |
|                  |                           |                               | [5] | -   | 1000 | mW   |
| Tj               | junction temperature      |                               |     | -   | 150  | °C   |
| T <sub>amb</sub> | ambient temperature       |                               |     | -55 | 150  | °C   |
| T <sub>stg</sub> | storage temperature       |                               |     | -65 | 150  | °C   |

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 6 cm<sup>2</sup>.
- [4] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.
- [5] Device mounted on an FR4 PCB, 4-layer copper, tin-plated mounting pad for collector 1 cm<sup>2</sup>.

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- (1) FR4 PCB, 4-layer copper, 1 cm<sup>2</sup>
- (2) FR4 PCB, single-sided copper, 6 cm<sup>2</sup>
- (3) FR4 PCB, single-sided copper, 1 cm<sup>2</sup>
- (4) FR4 PCB, 4-layer copper, standard footprint
- (5) FR4 PCB, single-sided copper, standard footprint

Fig. 2. Power derating curves

## 9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol               | Parameter                | Conditions |     | Min | Тур | Max | Unit |
|----------------------|--------------------------|------------|-----|-----|-----|-----|------|
| R <sub>th(j-a)</sub> | thermal resistance       |            | [1] | -   | -   | 385 | K/W  |
|                      | from junction to ambient |            | [2] | -   | -   | 209 | K/W  |
| anbient              | ambient                  |            | [3] | -   | -   | 169 | K/W  |
|                      |                          |            | [4] | -   | -   | 232 | K/W  |
|                      |                          |            | [5] | -   | -   | 125 | K/W  |

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated mounting pad for collector 6 cm<sup>2</sup>.
- [4] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.
- [5] Device mounted on an FR4 PCB, 4-layer copper, tin-plated mounting pad for collector 1 cm<sup>2</sup>.

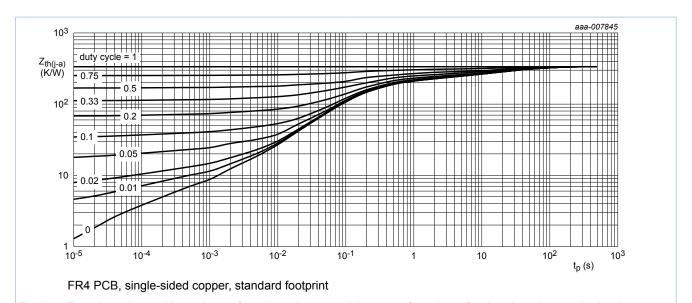


Fig. 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

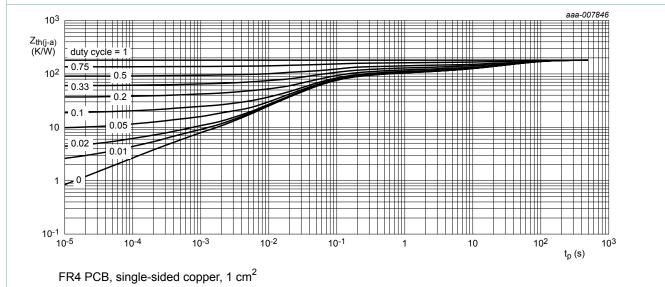


Fig. 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

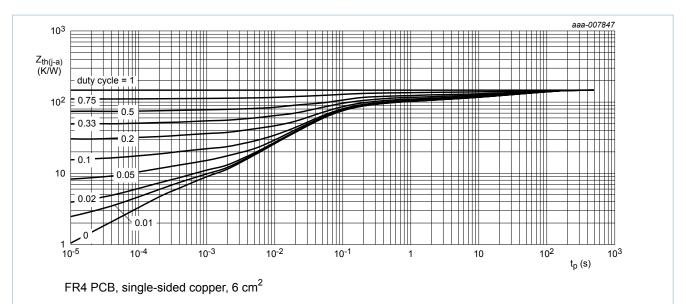


Fig. 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

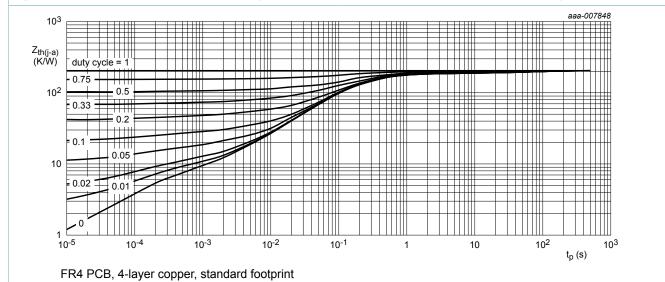
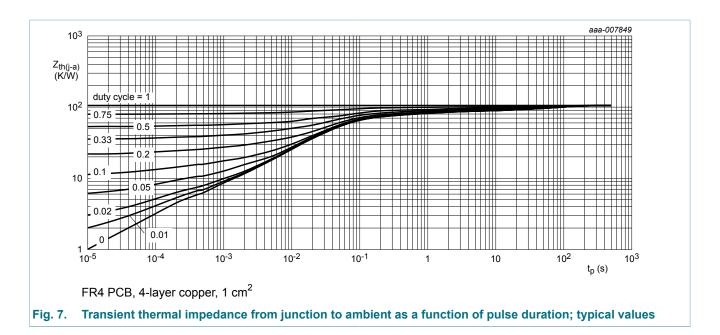


Fig. 6. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 60 V, 1 A PNP low VCEsat (BISS) transistor



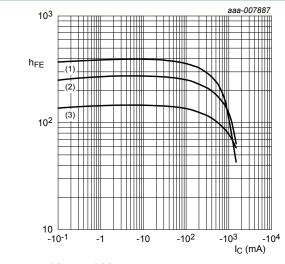
## 10. Characteristics

Table 7. Characteristics

| Symbol             | Parameter                               | Conditions  | Min | Тур  | Max  | Unit |
|--------------------|---|---|-----|------|------|------|
| I <sub>CBO</sub>   | collector-base cut-off                  | V <sub>CB</sub> = -48 V; I <sub>E</sub> = 0 A; T <sub>amb</sub> = 25 °C   | -   | -    | -100 | nA   |
|                    | current                                 | V <sub>CB</sub> = -48 V; I <sub>E</sub> = 0 A; T <sub>j</sub> = 150 °C  | -   | -    | -50  | μA   |
| I <sub>CES</sub>   | collector-emitter cut-off current       | V <sub>CE</sub> = -48 V; V <sub>BE</sub> = 0 V; T <sub>amb</sub> = 25 °C  | -   | -    | -100 | nA   |
| I <sub>EBO</sub>   | emitter-base cut-off current            | V <sub>EB</sub> = -5 V; I <sub>C</sub> = 0 A; T <sub>amb</sub> = 25 °C  | -   | -    | -100 | nA   |
| h <sub>FE</sub>    | DC current gain                         | $V_{CE}$ = -2 V; $I_{C}$ = -100 mA; $t_{p}$ ≤ 300 μs; $\delta$ ≤ 0.02 ; $T_{amb}$ = 25 °C; pulsed                 | 160 | 250  | -    |      |
|                    |   | $V_{CE}$ = -2 V; $I_{C}$ = -500 mA; $t_{p}$ ≤ 300 μs; $\delta$ ≤ 0.02 ; $T_{amb}$ = 25 °C; pulsed                 | 120 | 185  | -    |      |
|                    |   | $V_{CE}$ = -2 V; $I_{C}$ = -1 A; $t_{p}$ ≤ 300 µs; $\delta$ ≤ 0.02 ; $T_{amb}$ = 25 °C; pulsed                    | 85  | 125  | -    |      |
| V <sub>CEsat</sub> | collector-emitter saturation voltage    | $I_{C}$ = -500 mA; $I_{B}$ = -50 mA; $t_{p}$ ≤ 300 µs; $\delta$ ≤ 0.02 ; $T_{amb}$ = 25 °C                        | -   | -125 | -190 | mV   |
|                    |   | $I_C$ = -1 A; $I_B$ = -50 mA; $t_p$ ≤ 300 μs;<br>$\delta$ ≤ 0.02 ; $T_{amb}$ = 25 °C                              | -   | -315 | -460 | mV   |
|                    |   | $I_{C}$ = -1 A; $I_{B}$ = -100 mA; pulsed;<br>$t_{p} \le 300 \ \mu s$ ; $\delta \le 0.02$ ; $T_{amb}$ = 25 °C     | -   | -225 | -330 | mV   |
| R <sub>CEsat</sub> | collector-emitter saturation resistance | $I_{C}$ = -1 A; $I_{B}$ = -100 mA; pulsed;<br>$t_{p} \le 300  \mu\text{s}; \ \delta \le 0.02 ; \ T_{amb}$ = 25 °C | -   | 225  | 330  | mΩ   |

## 60 V, 1 A PNP low VCEsat (BISS) transistor

| Symbol           | Parameter                       | Conditions   | Min | Тур   | Max   | Unit |
|------------------|---------------------------------|--|-----|-------|-------|------|
| $V_{BEsat}$      | base-emitter saturation voltage | $I_{C}$ = -500 mA; $I_{B}$ = -50 mA; pulsed;<br>$t_{p} \le 300 \ \mu s; \ \delta \le 0.02 \ ; T_{amb}$ = 25 °C | -   | -0.88 | -1    | V    |
|                  |                                 | $I_{C}$ = -1 A; $I_{B}$ = -50 mA; pulsed;<br>$t_{p} \le 300 \ \mu s; \ \delta \le 0.02 \ ; T_{amb}$ = 25 °C    | -   | -0.94 | -1.05 | V    |
|                  |                                 | $I_{C}$ = -1 A; $I_{B}$ = -100 mA; pulsed;<br>$t_{p} \le 300 \ \mu s$ ; $\delta \le 0.02$ ; $T_{amb}$ = 25 °C  | -   | -0.97 | -1.1  | V    |
| $V_{BEon}$       | base-emitter turn-on voltage    | $V_{CE}$ = -2 V; $I_{C}$ = -0.5 A; pulsed;<br>$t_{p} \le 300 \ \mu s; \ \delta \le 0.02 \ ; T_{amb}$ = 25 °C   | -   | -0.8  | -0.9  | V    |
| t <sub>d</sub>   | delay time                      | $V_{CC}$ = -10 V; $I_{C}$ = -0.5 A; $I_{Bon}$ = -25 mA;  | -   | 15    | -     | ns   |
| t <sub>r</sub>   | rise time                       | I <sub>Boff</sub> = 25 mA; T <sub>amb</sub> = 25 °C  | -   | 35    | -     | ns   |
| t <sub>on</sub>  | turn-on time                    |  | -   | 50    | -     | ns   |
| t <sub>s</sub>   | storage time                    |  | -   | 300   | -     | ns   |
| t <sub>f</sub>   | fall time                       |  | -   | 50    | -     | ns   |
| t <sub>off</sub> | turn-off time                   |  | -   | 350   | -     | ns   |
| f <sub>T</sub>   | transition frequency            | $V_{CE}$ = -10 V; $I_{C}$ = -50 mA; f = 100 MHz; $T_{amb}$ = 25 °C   | 100 | 150   | -     | MHz  |
| C <sub>c</sub>   | collector capacitance           | V <sub>CB</sub> = -10 V; I <sub>E</sub> = 0 A; i <sub>e</sub> = 0 A;<br>f = 1 MHz; T <sub>amb</sub> = 25 °C    | -   | 12    | 15    | pF   |





<sup>(1)</sup>  $T_{amb} = 100 \, ^{\circ}C$ 

(3)  $T_{amb} = -55 \,^{\circ}C$ 

Fig. 8. DC current gain as a function of collector current; typical values

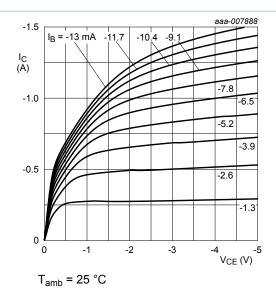
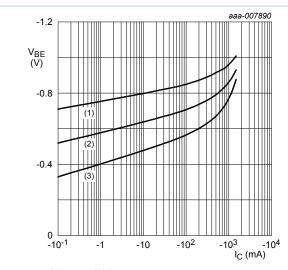


Fig. 9. Collector current as a function of collectoremitter voltage; typical values

<sup>(2)</sup>  $T_{amb}$  = 25 °C



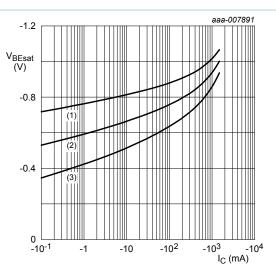
$$V_{CE} = -2 V$$

(1) 
$$T_{amb} = -55 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3) 
$$T_{amb} = 100 \, ^{\circ}C$$

Fig. 10. Base-emitter voltage as a function of collector current; typical values



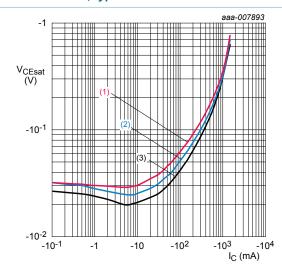
$$I_{\rm C}/I_{\rm B} = 20$$

(1) 
$$T_{amb} = -55 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3) 
$$T_{amb} = 100 \, ^{\circ}C$$

Fig. 11. Base-emitter saturation voltage as a function of collector current; typical values



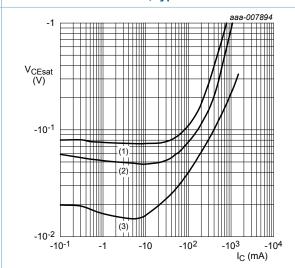
$$I_{\rm C}/I_{\rm B} = 20$$

(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb}$$
 = 25 °C

$$(3) T_{amb} = -55 °C$$

Fig. 12. Collector-emitter saturation voltage as a function of collector current; typical values

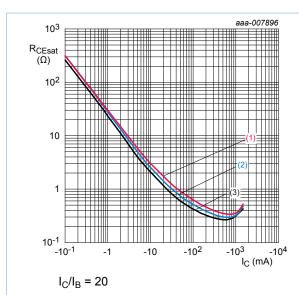


(1) 
$$I_C/I_B = 100$$

(2) 
$$I_C/I_B = 50$$

(3) 
$$I_C/I_B = 10$$

Fig. 13. Collector-emitter saturation voltage as a function of collector current; typical values

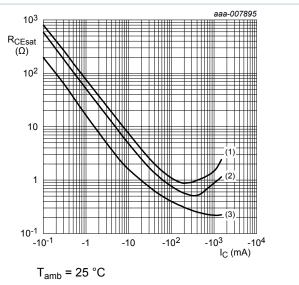


(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb}$$
 = 25 °C

(3) 
$$T_{amb} = -55 \, ^{\circ}C$$

Fig. 14. Collector-emitter saturation resistance as a function of collector current; typical values



(1) 
$$I_C/I_B = 100$$

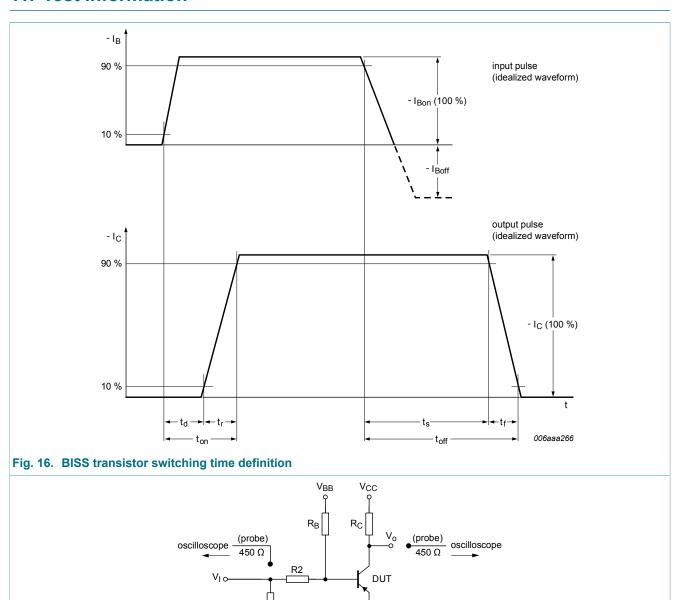
(2) 
$$I_C/I_B = 50$$

(3) 
$$I_C/I_B = 10$$

Fig. 15. Collector-emitter saturation resistance as a function of collector current; typical values

60 V, 1 A PNP low VCEsat (BISS) transistor

## 11. Test information



## 11.1 Quality information

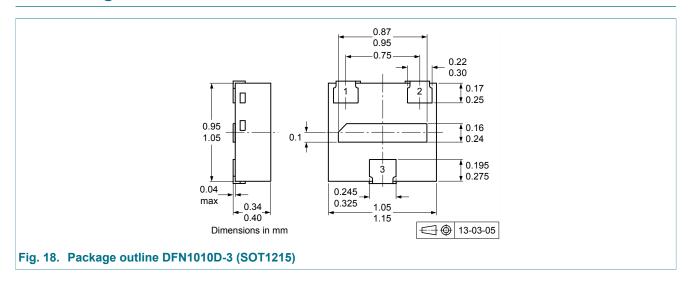
Fig. 17. Test circuit for switching times

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

mgd624

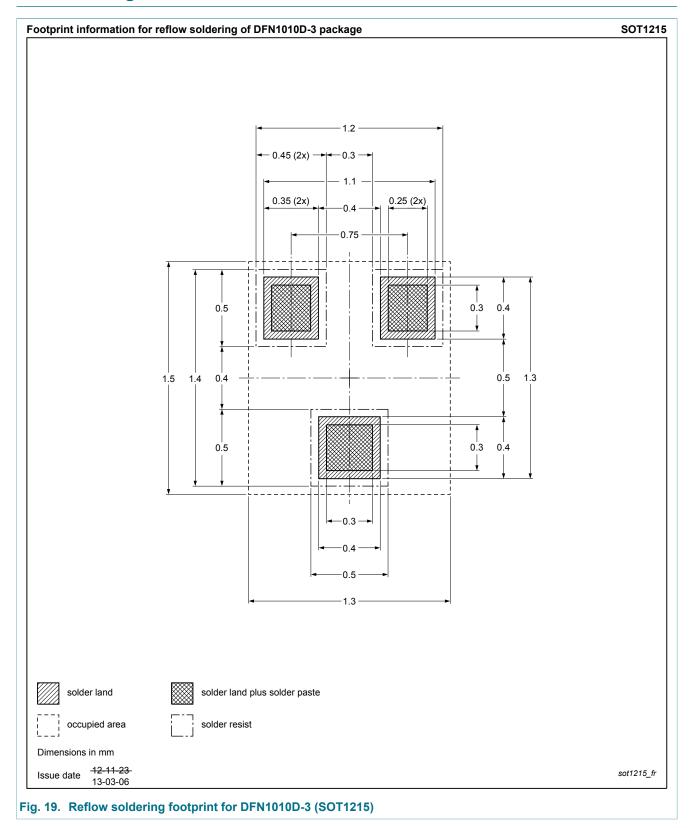
60 V, 1 A PNP low VCEsat (BISS) transistor

# 12. Package outline



60 V, 1 A PNP low VCEsat (BISS) transistor

# 13. Soldering



PBSS5160QA

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60 V, 1 A PNP low VCEsat (BISS) transistor

# 14. Revision history

#### Table 8. Revision history

| Data sheet ID  | Release date | Data sheet status  | Change notice | Supersedes |
|----------------|--------------|--------------------|---------------|------------|
| PBSS5160QA v.1 | 20130823     | Product data sheet | -             | -          |

#### 60 V, 1 A PNP low VCEsat (BISS) transistor

## 15. Legal information

#### 15.1 Data sheet status

| Document status [1][2]               | Product status [3] | Definition  |
|--------------------------------------|--------------------|---|
| Objective<br>[short] data<br>sheet   | Development        | This document contains data from the objective specification for product development. |
| Preliminary<br>[short] data<br>sheet | Qualification      | This document contains data from the preliminary specification.                       |
| Product<br>[short] data<br>sheet     | Production         | This document contains the product specification.                                     |

- Please consult the most recently issued document before initiating or completing a design.
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## 60 V, 1 A PNP low VCEsat (BISS) transistor

## 16. Contents

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